Notice of References Cited Application/Control No. 10/742,918 Examiner James A. Dudek Applicant(s)/Patent Under Reexamination KANG ET AL. Page 1 of 1 U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	Α	US-2004/0021810	02-2004	Kawaguri et al.	349/113
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